

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/767,780	FUKUI, SHINGO	
Examiner		Art Unit		Page 1 of 1
Patrick A. Darno		2163		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0076030 A1	04-2005	Hada et al.	707/009
*	B	US-2003/0061216 A1	03-2003	Moses, Fred	707/9
*	C	US-2003/0110246 A1	06-2003	Byrne et al.	709/223
*	D	US-6,026,402	02-2000	Vossen et al.	707/9
*	E	US-2003/0142824 A1	07-2003	Asano et al.	380/277
*	F	US-2006/0112177 A1	05-2006	Barkley et al.	709/224
*	G	US-2006/0212457 A1	09-2006	Pearce et al.	707/100
*	H	US-2006/0143179 A1	06-2006	Draluk et al.	707/009
*	I	US-2005/0010585 A1	01-2005	Sahinoja et al.	707/100
*	J	US-2006/0089932 A1	04-2006	Buehler et al.	707/010
*	K	US-2005/0289150 A1	12-2005	Kudo, Michiharu	707/010
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.